TOSHIBA TRANSISTOR SILICON NPN EPITAXIAL TYPE (PCT PROCESS)

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ULTRA HIGH SPEED SWITCHING APPLICATIONS. COMPUTER, COUNTER APPLICATIONS.

• High Transition Frequency : $f_T = 400MHz$ (Typ.)

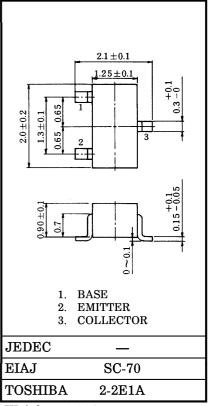
• Low Saturation Voltage : V_{CE (sat)} = 0.3V (Max.)

• High Speed Switching Time: t_{stg}=15ns(Typ.)

MAXIMUM RATINGS (Ta = 25°C)

CHARACTERISTIC	SYMBOL	RATING	UNIT
Collector-Base Voltage	v_{CBO}	40	V
Collector-Emitter Voltage	v_{CEO}	15	V
Emitter-Base Voltage	$v_{ m EBO}$	5	V
Collector Current	$I_{\mathbf{C}}$	200	mA
Base Current	$I_{\mathbf{B}}$	40	mA
Collector Power Dissipation	$P_{\mathbf{C}}$	100	mW
Junction Temperature	${ m T_{j}}$	125	°C
Storage Temperature Range	${ m T_{stg}}$	-55~125	°C

Unit in mm



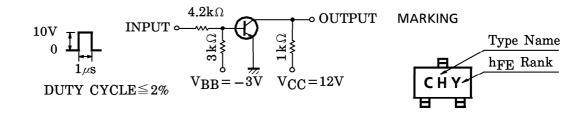
Weight: 0.006g

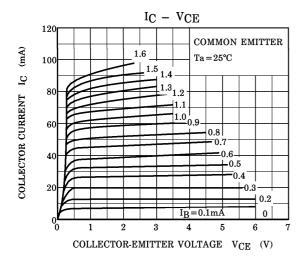
ELECTRICAL CHARACTERISTICS (Ta = 25°C)

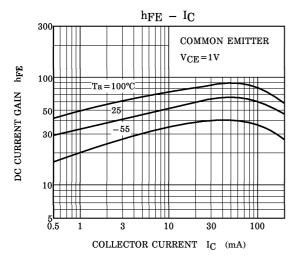
CHARAC	CTERISTIC	SYMBOL	TEST CONDITION	MIN.	TYP.	MAX.	UNIT
Collector Cu	t-off Current	I_{CBO}	$V_{CB} = 40V, I_{E} = 0$			0.1	μ A
Emitter Cut-	off Current	$I_{ m EBO}$	$V_{\mathrm{EB}} = 5V$, $I_{\mathrm{C}} = 0$	_	_	0.1	μ A
DC Current Gain		hFE (1) (Note 1)	$V_{ ext{CE}} = 1V$, $I_{ ext{C}} = 10 \text{mA}$	40	_	240	
		h _{FE (2)}	$V_{ ext{CE}} = 1V$, $I_{ ext{C}} = 100 \text{mA}$	20	_	_	
Collector-Em Voltage	itter Saturation	V _{CE} (sat)	$I_C=20mA$, $I_B=1mA$	_	_	0.3	V
Base-Emitter Voltage	Saturation	V _{BE} (sat)	$I_C=20$ mA, $I_B=1$ mA	_	_	1.0	v
Transition F	requency	${f f_T}$	$V_{\text{CE}} = 10V, I_{\text{C}} = 10\text{mA}$	200	400	_	MHz
Collector Ou Capacitance	tput	C_{ob}	$V_{CB} = 10V, I_E = 0, f = 1MHz$	_	4	6	pF
Switching Time	Turn-on Time	ton	(Note 2)	_	70	_	
	Storage Time	t_{stg}		_	15	_	ns
	Turn-off Time	$t_{ m off}$		_	30	_	

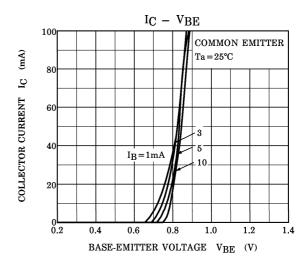
Note 1: $h_{FE(1)}$ Classification R: $40\sim80$, O: $70\sim140$, Y: $120\sim240$

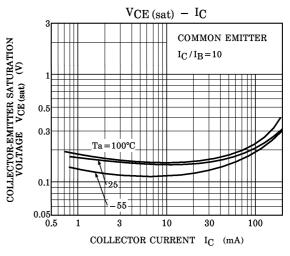
Note 2: SWITCHING TIME TEST CIRCUIT



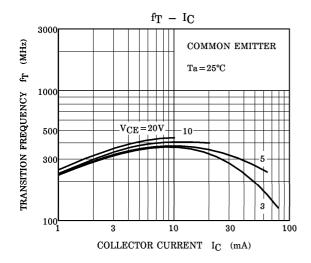


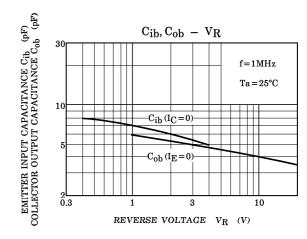


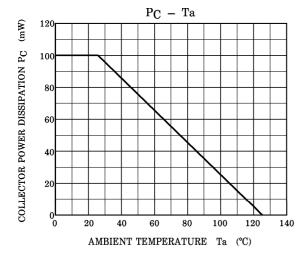




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